Signature Analysis Applied to EDS Microanalysis

J.W. Colby & D. C. Ward xk, Incorporated, Clackamas, OR¹ denniscward@earthlink.net

Most spectroscopies (FTIR, XRD, RAMAN, MS, etc.), were developed in order to identify materials. This is accomplished by capturing the spectral "signature" of an unknown and matching it to those of a comprehensive database of reference materials. Development of these spectroscopies has included efforts to embellish the associated database. EDS evolved as a resource to provide qual/quant, and development has been to improve the accuracy of quantation. Until recently, EDS was not considered a spectroscopy to provide identification of materials.

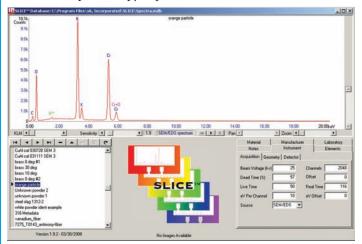


Figure 1 - Main spectral display window

In order to fully utilize SEM/EDS the Federal Bureau of Investigation evaluated the current capability to meet mission requirements for trace material characterization. It became readily apparent that a compositional approach was not sufficient, as; comparison of composition is not sufficiently discriminating, the composition of many materials is not known, and the determination of composition could not always be determined accurately for the variety of materials anticipated.

Even for the "suitable" sample, the difficulty in selecting the model and parameters for quantitation can be demonstrated in a computer program developed and patented by C. E. Fiori and C. R. Swyt at NIST in 1994, which allowed one to calculate a spectrum theoretically from a hypothetical sample. In use, the operator could pick any one of several models and parameters from many sources, to achieve the calculated spectrum, and as might be anticipated, the resulting spectra varied considerably. In fact, by choosing the parameters and model properly (or improperly), one could obtain nearly any result anticipated.

It appeared that a "traditional" spectroscopy approach to EDS could be a powerful addition to quantitation. Therefore, in 1998, the FBI awarded xk, Inc. a contract to develop a relational database architecture and software to query the database. This led to the development of SLICE™ (Spectral Library for Identification and Classification Explorer). The program and database have evolved into a fully functional database program, which not only includes the

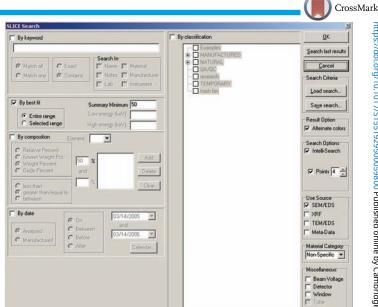


Figure 2 - Search Window for "Orange Particle"

spectra and chemistries, but also other metadata to facilitate and further refine the classification of spectra from unknown materials. Data mining, enhanced spectral display and comparisons, and a materials classification tree are also part of SLICE. In practice, the spectra in standard EMSA format as developed by Nestor Zaluzec, et.al. in 1991 and implemented by most EDS companies, are imported into SLICE. Chemistries may be imported if contained in the EMSA file, or may be determined within SLICE. Both peak ID and quant results may be executed within SLICE. Chemistries may be displayed as weight %, atomic %, relative %, or in the case of minerals, clay, etc., as oxide %. Any additional known metadata are added to the stored spectrum, including text notes, sources, physical and instrumental parameters, etc. In addition, the spectrum may be archived with SEM and optical images, x-ray maps, PDF documents, spreadsheets, etc, all readily retrievable. Laboratories or individuals may build their own database and materials classification tree (text document) to suit their particular requirements. The current database² contains nearly 6000 spectra, from many material categories (alloys, SRM materials, minerals, commercial products, etc.). The main window of SLICE is shown in Figure 1, and

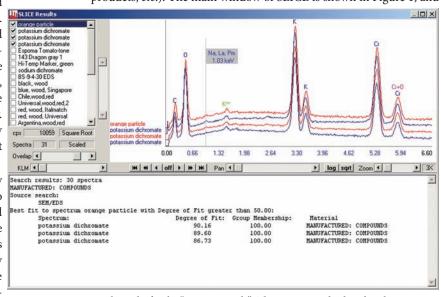
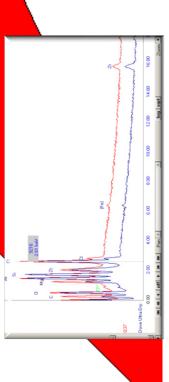


Figure 3 - Search results for the "orange particle". The spectra are displayed in the square root mode, and normalized about the cursor.

Did you know there is much more to EDS than qual and quant?





Explorer based data management







1000's of reference spectra



And much more ...

*Spectrum Library Identification and Classification Explorer

xk, Incorporated www.xk.com 503.799.6015

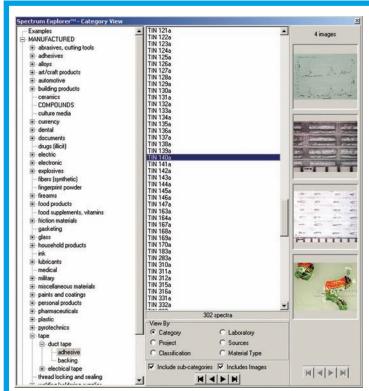


Figure 4, Spectrum Explorer, showing the classification tree on the far left, the associated images on the right, and the list of spectra in between. consists of the spectrum from an "orange particle", and the metadata stored under the various tabs.

The notes section may contain URLs in addition to text information, and clicking the URLs will link to the appropriate web site if an external internet connection is available. Clicking the image or other documents displayed will automatically open them to full size images or documents. In this case, no images were stored with the spectrum.

Users may create their own proprietary databases in addition to the one supplied with SLICE². In cases of failure analysis or defect revue, SLICE and the associated database become an historical resource of similar prior defect occurrences, comparable to forensic evidence relating to serial criminal activities. Since the failure analysis report (e.g. MS Word or PowerPoint document) may be associated with the spectrum as an "image", subsequent to the database query, a simple click opens the document for comparison to the current problem.

Queries can be executed based on key words (names, material, laboratory, etc., and text within the notes section), best fit, composition, date, properties, classification, instrument parameters, source, and source properties, separately or in combination with each other. As an example, from the Search Page (Figure 2), the database is searched to find likely candidates to identify/classify the "orange particle" shown in Figure 1. The best-fit algorithms have been developed and optimized to be relatively insensitive to instrumental and operating parameters, to avoid some of the problems listed above.

Spectra may be compared as the result of Search queries (Figure 3), or by direct choice from within the Spectrum Explorer shown in Figure 4. Compared spectra can be displayed in the usual linear and log modes, and in square root mode. Overlapped spectra may be tightly or loosely overlapped, and normalized at any point in the spectra, statically or dynamically to facilitate comparison. The number of spectra overlapped can be chosen dynamically, and the metadata can be examined

from any of the overlapped spectra. Data associated with the spectrum can also be tabulated.

The tabulated data can be properties specific to the material, or properties that are more general. Chemistries can also be tabulated (weight %, atomic %, etc.) and both chemistries and properties can be sorted in ascending or descending order. Statistics may also be displayed. The tabulated data can be copied and pasted into a document (e.g. MS Word or Excel) for further processing and/or report generation. The tabulated chemistries for the "orange particle" and potassium dichromate spectra are shown in Figure 5. The variations in chemistry are significant, and are due in part to the sample themselves not being flat, polished and homogeneous, as well as other uncertainties in the analysis. Nevertheless, the SLICE results strongly point to the particles being potassium dichromate. No other database entries are remotely close.

The majority of spectra in the current database are SEM/EDS spectra but TEM/EDS and XRF/EDS spectra are also included, and spectra of one type can be searched against spectra of another type (e.g. unknown XRF spectrum against both SEM and TEM spectra) although in general better results can be obtained against spectra of the same type.

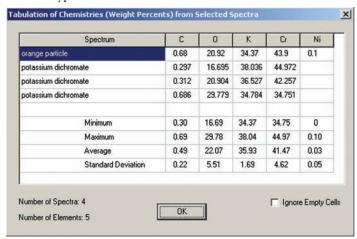


Figure 5 – Tabulated chemistries as weight percents from the "orange particle" and other potassium dichromate spectra

By providing utilities for archiving and querying data, SLICE provides EDS with significantly enhanced capability, putting it on a par with other, more classical spectroscopy. Although EDS has not historically been considered a spectroscopy that provides "identification," the inclusion of this capability is significant for disciplines such as forensics, failure analysis, and process control, where material sourcing is required.

References:

- 1. www.xk.com
- The original spectral database for this project was heavily populated by the FBI. The database, as subsequently modified is provided with SLICE.

Editor's Note

This article was submitted along with the included advertisement in mid-May 2008 with instructions to place both items in the July 2008 MT issue. By mistake, I placed the article in the May issue, which upset xk's marketing plan. For this I extend my apologies. I deemed repeating the article, along with the advertisement in the July issue where it belongs as the only fair solution to this situation. Ron Anderson, MT Editor

DiATOME diamond knives

Development, Manufacturing, and Customer Service since 1970

What have we achieved in this period?

ultra 45° the first diamond knife with an absolutely score-free, hydrophilic cutting edge.

semi the first diamond knife for alternating sectioning ultrathin/semithin.

cryo the diamond knife for sectioning at low temperature.

histo the first diamond knife for semithin sections for light microscopy.

ultra 35° the diamond knife for optimized sectioning results in almost all applications.

STATIC LINE II the ionizer for eliminating electrostatic charging in ultramicrotomy.

cryo-P a cryo knife with a patented platform for section pick up.

cryo immuno the optimized cryo diamond knife for the Tokuyasu technique.

ultra sonic the oscillating diamond knife for room temperature sectioning.

cryotrim 45 and 25 optimizing trimming with diamond blades.

ultra AFM & cryo AFM the first diamond knives for AFM at room and low temperatures.

cryo 25° for sectioning frozen hydrated specimens.

What services can we offer you?

- Technical assistance in all fields of ultramicrotomy.
- Free sectioning tests for all types of samples.
- Make use of our many years of experience in perfecting our knives.
- Custom knives, tools, and boats.
- Special purchase programs.
- Workshops and training.



For more information, please call or write us today, or visit us online at:

www.emsdiasum.com

DIATOME

for all your sectioning requirements

P.O. Box 410 • 1560 Industry Rd. Hatfield, Pa 19440 (215) 412-8390 • Toll Free: 1-(800) 523-5874 Fax: (215) 412-8450 or 8452

email: sqkcck@aol.com • stacie@ems-secure.com

www.emsdiasum.com